



Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from,Europe,America and south Asia,supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts,Customers Priority,Honest Operation,and Considerate Service",our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China



Data Sheet

HAL[®] 2455

High-Precision Programmable
Linear Hall-Effect Sensor
with PWM Output

Copyright, Warranty, and Limitation of Liability

The information and data contained in this document are believed to be accurate and reliable. The software and proprietary information contained therein may be protected by copyright, patent, trademark and/or other intellectual property rights of Micronas. All rights not expressly granted remain reserved by Micronas.

Micronas assumes no liability for errors and gives no warranty representation or guarantee regarding the suitability of its products for any particular purpose due to these specifications.

By this publication, Micronas does not assume responsibility for patent infringements or other rights of third parties which may result from its use. Commercial conditions, product availability and delivery are exclusively subject to the respective order confirmation.

Any information and data which may be provided in the document can and do vary in different applications, and actual performance may vary over time.

All operating parameters must be validated for each customer application by customers' technical experts. Any new issue of this document invalidates previous issues. Micronas reserves the right to review this document and to make changes to the document's content at any time without obligation to notify any person or entity of such revision or changes. For further advice please contact us directly.

Do not use our products in life-supporting systems, military, aviation, or aerospace applications! Unless explicitly agreed to otherwise in writing between the parties, Micronas' products are not designed, intended or authorized for use as components in systems intended for surgical implants into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the product could create a situation where personal injury or death could occur.

No part of this publication may be reproduced, photocopied, stored on a retrieval system or transmitted without the express written consent of Micronas.

Micronas Trademarks

– HAL

Third-Party Trademarks

All other brand and product names or company names may be trademarks of their respective companies.

Contents

Page	Section	Title
4	1.	Introduction
4	1.1.	Major Applications
4	1.2.	Features
5	2.	Ordering Information
5	2.1.	Device-Specific Ordering Codes
6	3.	Functional Description
6	3.1.	General Function
7	3.2.	Signal Path and Register Definition
7	3.2.1.	Signal Path
7	3.2.2.	Register Definition
7	3.2.2.1.	RAM registers
10	3.2.2.2.	EEPROM Registers
12	3.2.2.3.	NVRAM Registers
12	3.2.2.4.	Setpoint Linearization Accuracy
13	3.3.	On-Board Diagnostic Features
13	3.4.	Calibration of the Sensor
14	4.	Specifications
14	4.1.	Outline Dimensions
20	4.2.	Soldering, Welding and Assembly
20	4.3.	Pin Connections and Short Descriptions
21	4.4.	Sensitive Area
21	4.4.1.	Dimensions
21	4.4.2.	Package Parameter and Position
22	4.5.	Absolute Maximum Ratings
22	4.5.1.	Storage and Shelf Life
23	4.6.	Recommended Operating Conditions
24	4.7.	Characteristics
25	4.8.	Overvoltage and Undervoltage Detection
25	4.9.	Magnetic Characteristics
26	4.9.1.	Definition of Sensitivity Error ES
27	5.	Application Notes
27	5.1.	Application Circuit
27	5.2.	Measurement of a PWM Output Signal of HAL 2455
27	5.3.	Use of two HAL 2455 in Parallel
27	5.4.	Ambient Temperature
27	5.5.	EMC and ESD
28	6.	Programming of the Sensor
28	6.1.	Programming Interface
29	6.2.	Programming Environment and Tools
29	6.3.	Programming Information
30	7.	Data Sheet History

High-Precision Programmable Linear Hall-Effect Sensor with PWM Output

Release Note: Revision bars indicate significant changes to the previous edition.

1. Introduction

The HAL 2455 is a new member of the HAL 24xy family of programmable linear Hall-effect sensors from Micronas.

The device is a universal magnetic field sensor based on the Hall effect featuring a PWM output. Major characteristics like magnetic field range, and sensitivity are programmable in a non-volatile memory. The sensor offers wire-break detection.

The HAL 2455 offers 16 setpoints to change the output characteristics from linear to arbitrary or vice versa.

The HAL 2455 features a temperature-compensated Hall plate with spinning-current offset compensation, an A/D converter, digital signal processing, a PWM output module, an EEPROM with redundancy and lock function for calibration data, a serial interface for programming the EEPROM, and protection devices at all pins. The internal digital signal processing prevents the signal being influenced by analog offsets, temperature shifts, and mechanical stress.

The easy programmability allows a 2-point calibration by adjusting the output signal directly to the input signal (like mechanical angle, distance, or current). Individual adjustment of each sensor during the final manufacturing process is possible. With this calibration procedure, the tolerances of the sensor, the magnet and the mechanical positioning can be compensated in the final assembly.

In addition, the temperature compensation of the Hall IC can be fit to all common magnetic materials by programming first- and second-order temperature coefficients of the Hall sensor sensitivity.

It is also possible to compensate offset drift over temperature generated by the customer application with a first-order temperature coefficient for the sensor's offset. This enables operation over the full temperature range with high accuracy.

The calculation of the individual sensor characteristics and the programming of the EEPROM can easily be done with a PC and the application kit from Micronas.

The sensor is designed for stringent industrial and automotive applications and is AECQ100 qualified. It operates with typically 5 V supply voltage in the junction temperature range from $-40\text{ }^{\circ}\text{C}$ up to $170\text{ }^{\circ}\text{C}$. The HAL 2455 is available in the 3-pin package TO92UT-1/-2 and surface-mount SOIC8 packages.

1.1. Major Applications

Due to the sensor's versatile programming characteristics and low temperature drifts, the HAL 2455 is the optimal system solution for applications such as:

- Contactless potentiometers,
- Angle sensors (e.g. for transmission applications)
- Distance and linear movement measurements

1.2. Features

- High-precision linear Hall-effect sensor with 12-bit accuracy and PWM output up to 2 kHz
- 16 setpoints for various output signal shapes
- 16 bit digital signal processing
- Multiple customer-programmable magnetic characteristics in a non-volatile memory with redundancy and lock function
- Programmable temperature compensation for sensitivity and offset
- Magnetic field measurements in the range up to $\pm 200\text{ mT}$
- Active open-circuit (ground and supply line break detection) with $5\text{ k}\Omega$ pull-up and pull-down resistor, overvoltage and undervoltage detection
- Programmable clamping function
- Digital readout of temperature and magnetic field information in calibration mode
- Programming and operation of multiple sensors at the same supply line
- High immunity against mechanical stress, ESD, and EMC
- Operates from $T_J = -40\text{ }^{\circ}\text{C}$ up to $170\text{ }^{\circ}\text{C}$
- Operates from 4.5 V up to 5.5 V supply voltage in specification and functions up to 8.5 V
- Operates with static magnetic fields and dynamic magnetic fields up to 2 kHz
- Overvoltage and reverse-voltage protection at all pins

2. Ordering Information

A Micronas device is available in a variety of delivery forms. They are distinguished by a specific ordering code:

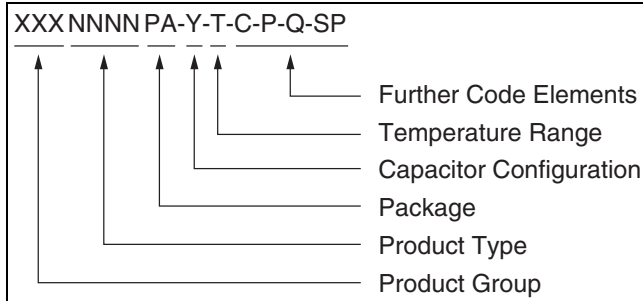


Fig. 2–1: Ordering Code Principle

For a detailed information, please refer to the brochure: “Hall Sensors: Ordering Codes, Packaging, Handling”.

2.1. Device-Specific Ordering Codes

HAL 2455 is available in the following package and temperature variants.

Table 2–1: Available packages

Package Code (PA)	Package Type
UT	TO92UT-1/-2
DJ	SOIC8-1

Table 2–2: Available temperature ranges

Temperature Code (T)	Temperature Range
A	$T_J = -40\text{ °C to }+170\text{ °C}$

The relationship between ambient temperature (T_A) and junction temperature (T_J) is explained in Section 5.4. on page 27.

For available variants for Configuration (C), Packaging (P), Quantity (Q), and Special Procedure (SP) please contact Micronas.

Table 2–3: Available ordering codes and corresponding package marking

Available Ordering Codes	Package Marking
HAL2455UT-A-[C-P-Q-SP]	2455A
HAL2455DJ-A-[C-P-Q-SP]	2455A

3. Functional Description

3.1. General Function

The HAL 2455 is a monolithic integrated circuit which provides a PWM output signal proportional to the magnetic flux through the Hall plate.

The external magnetic field component perpendicular to the branded side of the package generates a Hall voltage. The Hall IC is sensitive to magnetic north and south polarity. This voltage is converted to a digital value, processed in the Digital Signal Processing Unit (DSP) according to the settings of the EEPROM registers, and output as PWM signal.

The setting of a LOCK bit disables the programming of the EEPROM memory for all time. This bit cannot be reset by the customer.

As long as the LOCK bit is not set, the output characteristic can be adjusted by programming the EEPROM registers. The IC is addressed by modulating the output voltage.

In the supply voltage range from 4.5 V up to 5.5 V, the sensor generates a PWM signal. After detecting a command, the sensor reads or writes the memory and answers with a digital signal on the output pin. Several sensors in parallel to the same supply and ground line can be programmed individually. The selection of each sensor is done via its output pin. See Programming Guide HAL 24xy and HAR 24xy.

The open-circuit detection provides a defined output voltage if the V_{SUP} or GND line is broken.

Internal temperature compensation circuitry and the spinning-current offset compensation enable operation over the full temperature range with minimal changes in accuracy and high offset stability. The circuitry also reduces offset shifts due to mechanical stress from the package. In addition, the sensor IC is equipped with devices for overvoltage and reverse-voltage protection at all pins.

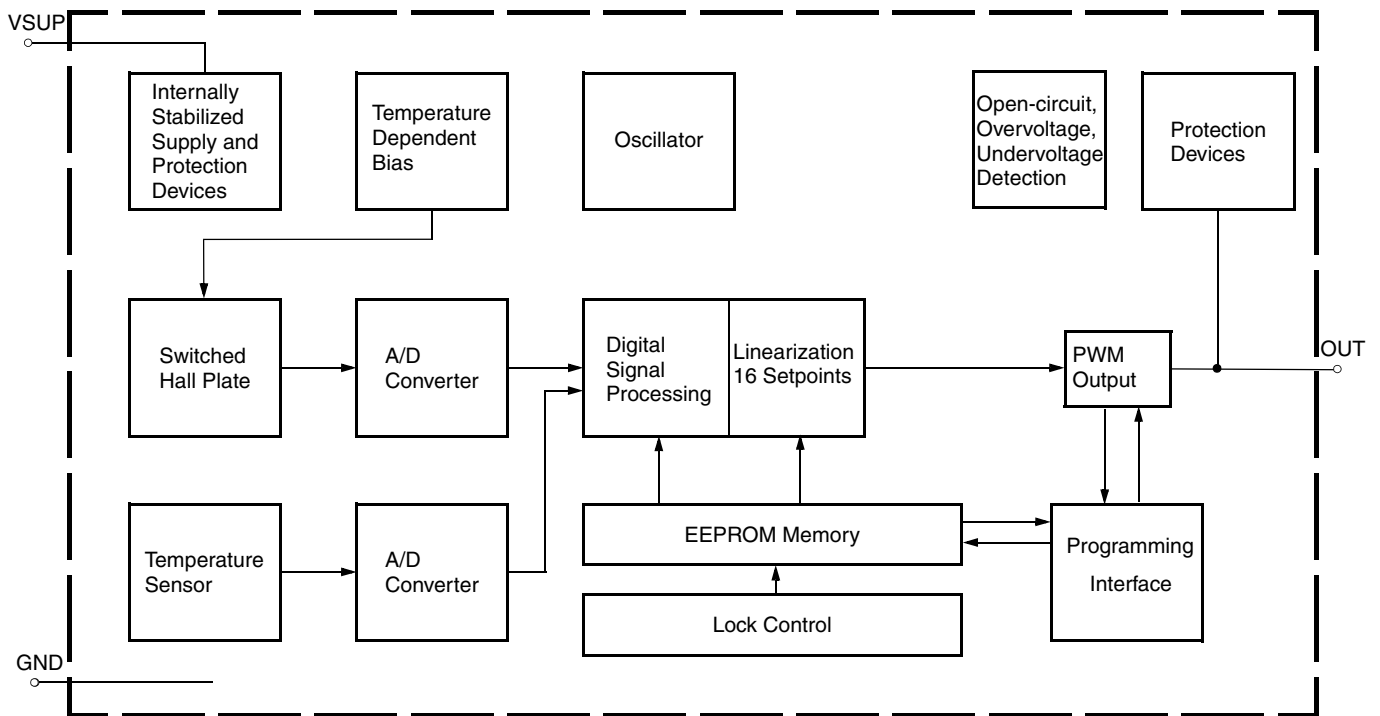


Fig. 3–1: HAL 2455 block diagram

3.2. Signal Path and Register Definition

3.2.1. Signal Path

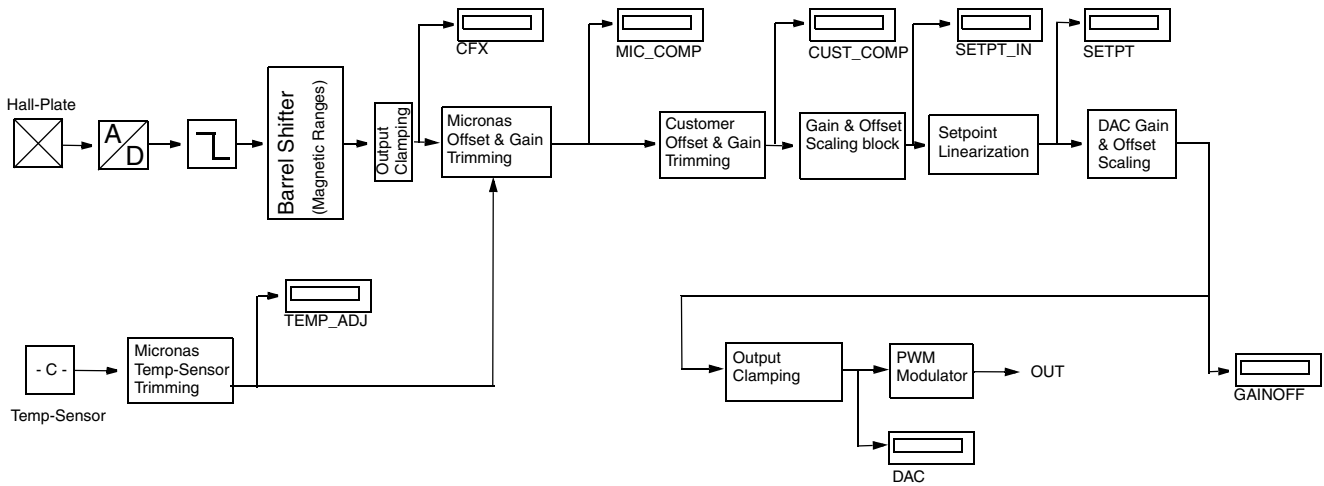


Fig. 3–2: Signal path of HAL 2455

3.2.2. Register Definition

The DSP is the major part of this sensor and performs the signal conditioning. The parameters for the DSP are stored in the EEPROM registers. The details are shown in Fig. 3–2 and Fig. 3–3.

Terminology:

GAIN: Name of the register or register value

Gain: Name of the parameter

The sensors signal path contains two kinds of registers. Registers that are readout only (RAM) and programmable registers (EEPROM & NVRAM). The RAM registers contain measurement data at certain positions of the signal path and the EEPROM registers have influence on the sensors signal processing.

3.2.2.1. RAM registers

TEMP_ADJ

The TEMP_ADJ register contains the calibrated temperature sensor information. TEMP_ADJ can be used for the sensor calibration over temperature. This register has a length of 16 bit and it is two’s-complement coded. Therefore the register value can vary between –32768...32767.

CFX

The CFX register is representing the magnetic field information directly after A/D conversion, decimation filter and magnetic range (barrel shifter) selection. The register content is not temperature compensated. The temperature variation of this register is specified in Section 4.9. on page 25 by the parameter RANGE_{ABS}.

Note: During application design, it must be taken into consideration that CFX should never overflow in the operational range of the specific application and especially over the full temperature range. In case of a potential overflow the barrel shifter should be switched to the next higher range.

This register has a length of 16 bit and it is two’s-complement coded. Therefore the register value can vary between –32768...32767. CFX register values will increase for positive magnetic fields (south pole) on the branded side of the package (positive CFX values) and it will decrease with negative magnetic field polarity.

MIC_COMP

The MIC_COMP register is representing the magnetic field information directly after the Micronas temperature trimming. The register content is temperature compensated and has a typical gain drift over temperature of 0 ppm/k. Also the offset and its drift over temperature is typically zero. The register has a length of 16 bit and it is two’s-complement coded. Therefore the register value can vary between –32768...32767.

CUST_COMP

The CUST_COMP register is representing the magnetic field information after the customer temperature trimming. For HAL 2455 it is possible to set a customer specific gain of second order over temperature as well as a customer specific offset of first order over temperature. The customer gain and offset can be set with the EEPROM registers TCCO0, TCCO1 for offset and TCCG0...TCCG2 for gain. Details of these registers are described on the following pages.

The register has a length of 16 bit and it is two's-complement coded. Therefore the register value can vary between -32768...32767.

SETPT_IN

The SETPT_IN register offers the possibility to read the magnetic field information after the scaling of the input signal to the input range of the linearization block. For further details see the description of the EEPROM registers SCALE_GAIN and SCALE_OFFSET that are described in the next chapter.

The register has a length of 16 bit and it is two's-complement coded. Therefore the register value can vary between -32768...32767.

SETPT

The SETPT register offers the possibility to read the magnetic field information after the linearization of the magnetic field information with 16 setpoints. This information is also required for the correct setting of the sensors DAC GAIN and OFFSET in the following block.

The register has a length of 16 bit and it is two's-complement coded. Therefore the register value can vary between -32768...32767.

GAINOFF

The GAINOFF register offers the possibility to read the magnetic field information after the DAC GAIN and OFFSET scaling.

This register has a length of 16 bit and it is two's-complement coded. Therefore the register value can vary between -32768...32767.

MIC_ID1 and MIC_ID2

The two registers MIC_ID1 and MIC_ID2 are used by Micronas to store production information like, wafer number, die position on wafer, production lot, etc. Both registers have a length of 16 bit each and are readout only.

PWM Frequency

The PWM frequency is selectable by 2 bits, which are part of the CUSTOMER SETUP register (bits 11:10). The CUSTOMER SETUP register is described on the following pages. The following four different frequencies can be used:

Table 3–1: Selectable PWM frequencies

PWM_FREQ		Frequency	Resolution
Bit 11	Bit 10		
1	1	2 kHz	11 bit
0	0	1 kHz	12 bit
0	1	500 Hz	12 bit
1	0	250 Hz	12 bit

DIAGNOSIS

The DIAGNOSIS register enables the customer to identify certain failures detected by the sensor. HAL 2455 performs certain self tests during power-up of the sensor and also during normal operation. The result of these self tests is stored in the DIAGNOSIS register. DIAGNOSIS register is a 16 bit register.

Bit no.	Function	Description
15:6	None	Reserved
5	State Machine (DSP) Self test	This bit is set to 1 in case that the statemachine self test fails. (continuously running)
4	EEPROM Self test	This bit is set to 1 in case that the EEPROM self test fails. (Performed during power-up only)
3	ROM Check	This bit is set to 1 in case that ROM parity check fails. (continuously running)
2	AD converter overflow	This bit is set to 1 in case the input signal is too high, indicating a problem with the magnetic range.
1:0	None	Reserved

Details on the sensor self tests can be found in Section 3.3. on page 13.

PROG_DIAGNOSIS

The PROG_DIAGNOSIS register enables the customer to identify errors occurring during programming and writing of the EEPROM or NVRAM memory. The customer must either check the status of this register after each write or program command or alternatively the second acknowledge. Please check the Programming Guide for HAL 24xy.

The PROG_DIAGNOSIS register is a 16 bit register. The following table shows the different bits indicating certain errors possibilities.

Bit no.	Function	Description
15:11	None	Reserved
10	Charge Pump Error	This bit is set to 1 in case that the internal programming voltage was to low
9	Voltage Error during Program/ Erase	This bit is set to 1 in case that the internal supply voltage was to low during program or erase
8	NVRAM Error	This bit is set to 1 in case that the programming of the NVRAM failed
7:0	Programming	For further information please refer to the Programming Guide for HAL 24xy

3.2.2.2. EEPROM Registers

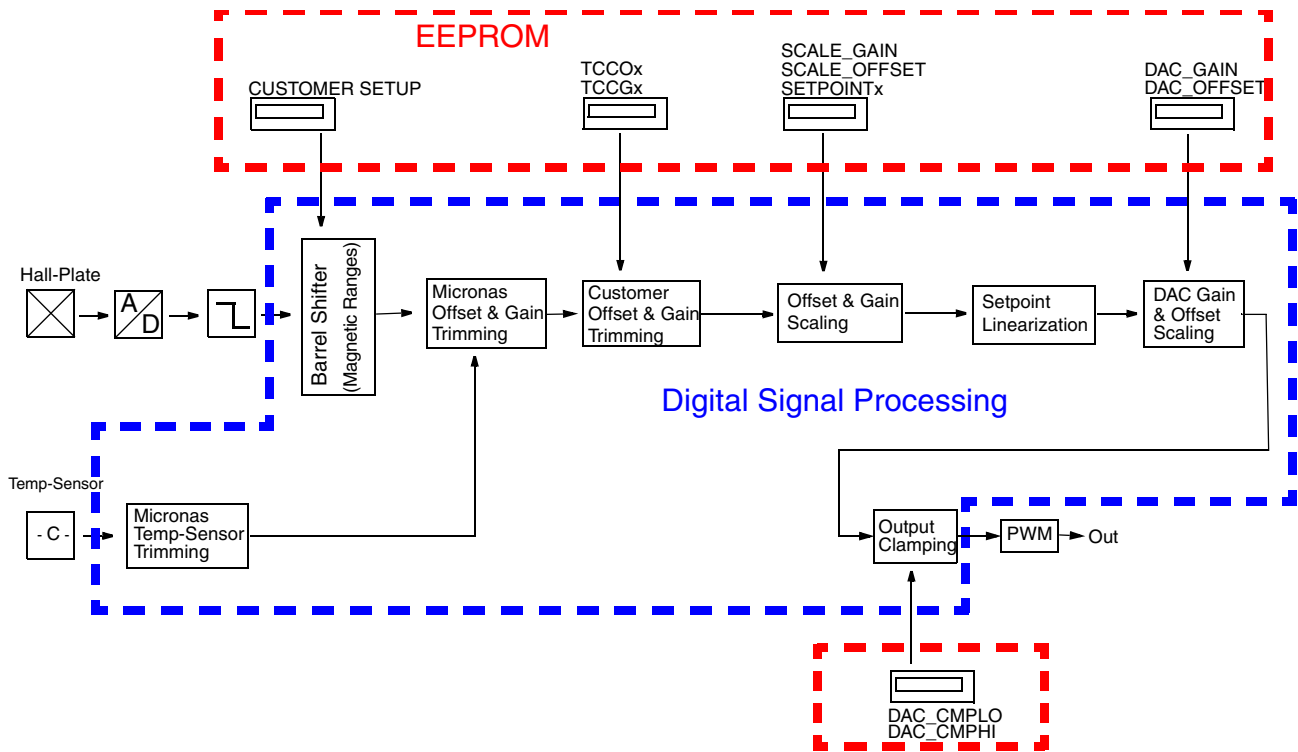


Fig. 3–3: Details of EEPROM and Digital Signal Processing

CUST_ID1 and CUST_ID2

The two registers CUST_ID1 and CUST_ID2 can be used to store customer information. Both registers have a length of 16 bit each.

Barrel Shifter (Magnetic Ranges)

The signal path of HAL 2455 contains a Barrel Shifter to emulate magnetic ranges. The customer can select between different magnetic ranges by changing the Barrel shifter setting. After decimation filter the signal path has a word length of 22 bit. The Barrel Shifter selects 16 bit out of the available 22 bit.

Table 3–2: Relation between Barrel Shifter setting and emulated magnetic range

BARREL SHIFTER	Used bits	Typ. magnetic range
0	22...7	not used
1	21...6	± 200 mT
2	20...5	± 100 mT
3	19...4	± 50 mT
4	18...3	± 25 mT
5	17...2	± 12 mT
6	16...1	± 6 mT

The Barrel Shifter bits are part of the CUSTOMER SETUP register (bits 14...12). The CUSTOMER SETUP register is described on the following pages.

Note: In case that the external field exceeds the magnetic field range the CFX register will be clamped either to -32768 or 32767 depending on the sign of the magnetic field.

Magnetic Sensitivity TCCG

The TCCG (Sensitivity) registers (TCCG0...TCCG2) contain the customer setting temperature dependant gain factor. The multiplication factor is a second order polynomial of the temperature.

All three polynomial coefficients have a bit length of 16 bit and they are two's-complement coded. Therefore the register values can vary between $-32768...32767$. In case that the target polynomial is based on normalized values, then each coefficient can vary between $-4 ... +4$. To store each coefficient into the EEPROM it is necessary to multiply the normalized coefficients with 32768.

Example:

- $Tccg0 = 0.5102 \Rightarrow TCCG0 = 16719$
- $Tccg1 = -0.0163 \Rightarrow TCCG1 = -536$
- $Tccg2 = 0.0144 \Rightarrow TCCG2 = 471$

In case that the polynomial was calculated based on not normalized values of TEMP_ADJ and MIC_COMP, then it is not necessary to multiply the polynomial coefficients with a factor of 32768.

Magnetic TCCO

The TCCO (Offset) registers (TCCO0 and TCCO1) contain the parameters for temperature dependant offset correction. The offset value is a first order polynomial of the temperature.

Both polynomial coefficients have a bit length of 16 bit and they are two's-complement coded. Therefore the register values can vary between $-32768...32767$. In case that the target polynomial is based on normalized values, then each coefficient can vary between $-4 ... +4$. To store each coefficient into the EEPROM it is necessary to multiply the normalized coefficients with 32768.

In case that the polynomial was calculated based on not normalized values of TEMP_ADJ and MIC_COMP, then it is not necessary to multiply the polynomial coefficients.

SETPOINTS

HAL 2455 features a linearization function based on 16 setpoints. The setpoint linearization in general allows to linearize a given output characteristic by applying the inverse compensation curve.

Each of the 16 setpoints (SETPT) registers has a length of 16 bit. The setpoints have to be computed and stored in a differential way. This means that if all setpoints are set to 0, then the linearization is set to neutral and a linear curve is used.

Sensitivity and Offset Scaling before Setpoint Linearization SCALE_GAIN/SCALE_OFFSET

The setpoint linearization uses the full 16 bit number range $0...32767$ (only positive values possible). So the signal path should be properly scaled for optimal usage of all 16 setpoints.

For optimum usage of the number range an additional scaling stage is added in front of the set point algorithm. The setpoint algorithm allows positive input numbers only.

The input scaling for the linearization stage is done with the EEPROM registers SCALE_GAIN and SCALE_OFFSET. The register content is calculated based on the calibration angles. Both registers have a bit length of 16 bit and are two's-complement coded.

Output Signal Scaling with DAC_GAIN/DAC_OFFSET

The required output duty cycle of the output is defined by the registers DAC_GAIN (Gain of the output) and DAC_OFFSET (Offset of the output signal). Both register values can be calculated based on the angular range and the required output PWM duty cycle range. They have a bit length of 16 bit and are two's-complement coded.

Clamping Levels DAC_CMPHI/DAC_CMPLO

The clamping levels DAC_CMPHI and DAC_CMPLO define the duty cycle of the output and define the diagnosis band for the sensor output. Both registers have a bit length of 16 bit and are two's-complement coded. Both clamping levels can have values between 0% and 100% of full scale.

3.2.2.3. NVRAM Registers

Customer Setup

The CUST_SETUP register is a 16 bit register that enables the customer to activate various functions of the sensor like customer burn-in mode, diagnosis modes, functionality mode, customer lock, etc.

Bit OP configures the PWM output polarity: a PWM period starts either with a high pulse (OP = 0) or with a low pulse (OP = 1). Please note that OP set to 1 is only effective after the device had been locked (LC=1)

Table 3-3: Functions in CUST_SETUP register

Bit No.	Function	Description
15	None	Reserved
14:12	Barrel Shifter	Magnetic Range (see Section Table 3-2: on page 10)
11:10	PWM frequency setting	PWM frequency selection (see Table 3-1 on page 8)
9:8	None	Reserved
7	PWM Output Polarity (OP)	0: PWM period starts with a high pulse 1: PWM period starts with a low pulse (effective after LC=1)
6	None	Reserved
5	Functionality Mode	1: Normal
4	Communication Mode (POUT)	0: Disabled 1: Enabled
3	Overvoltage Detection	0: Overvoltage detection active 1: Overvoltage detection disabled
2	Diagnosis Latch	Latching of diagnosis bits 0: No latching 1: Latched till next POR (power-on reset)
1	Diagnosis	0: Diagnosis errors force the PWM output into error mode (see Table 3-4) 1: Diagnosis errors do not force the PWM output into error mode
0	Customer Lock (LC)	Bit must be set to 1 to lock the sensor memory

3.2.2.4. Setpoint Linearization Accuracy

The set point linearization in general allows to linearize a given output characteristic by applying the inverse compensation curve.

For this purpose the compensation curve will be divided into 16 segments with equal distance. Each segment is defined by two setpoints, which are stored

in EEPROM. Within the interval, the output is calculated by linear interpolation according to the position within the interval.

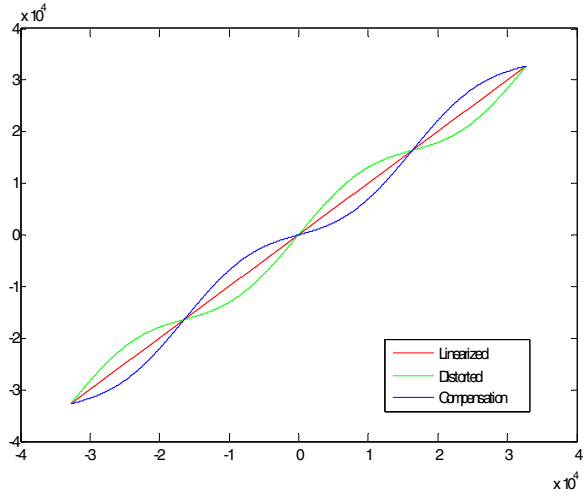


Fig. 3-4: Linearization - Principle

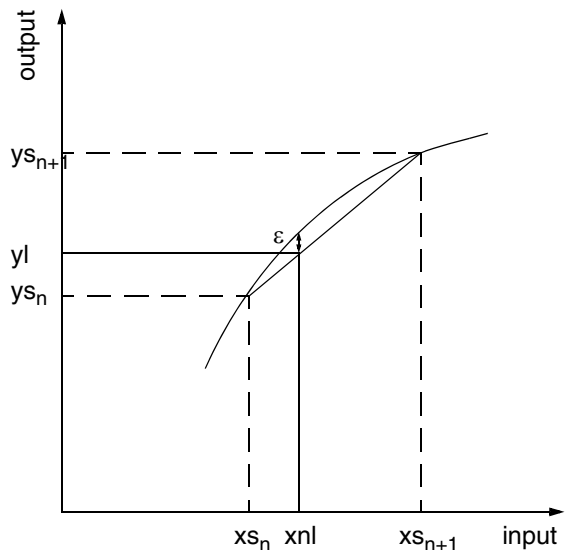


Fig. 3-5: Linearization - Detail

xnl: non linear distorted input value
yl: linearized value
 ϵ : remaining error

The constraint of the linearization is that the input characteristic has to be a monotonic function. In addition to that it is recommended that the input does not have a saddle point or inflection point, i.e. regions where the input is nearly constant. This would require a high density of set points.

3.3. On-Board Diagnostic Features

The HAL 2455 features two groups of diagnostic functions. The first group contains basic functions that are always active. The second group can be activated by the customer and contains supervision and self-tests related to the signal path and sensor memory.

Diagnostic Features that are Always Active:

- Wire break detection for supply and ground line
- Undervoltage detection
- Thermal supervision of output stage: overcurrent, short circuit, etc.

Diagnostic Features that can be Activated by Customer:

- Overvoltage detection
- EEPROM self-test at power-on
- Continuous ROM parity check
- Continuous state machine self-test
- Adder overflow

Failure Indication

The HAL 2455 indicates a failure by changing the PWM frequency. The different errors are then coded in different duty-cycles.

Table 3–4: Failure indication for HAL 2455

Failure Mode	Frequency	Duty-Cycle
EEPROM and state machine self-test	50%	95%
Adder overflow	50%	85%
Overvoltage	50%	75%
Undervoltage	50%	100%

Note: In case of an error the sensor changes the selected PWM frequency. Example:
 During normal operation the PWM frequency is 1 kHz, in case of an error 500 Hz.

3.4. Calibration of the Sensor

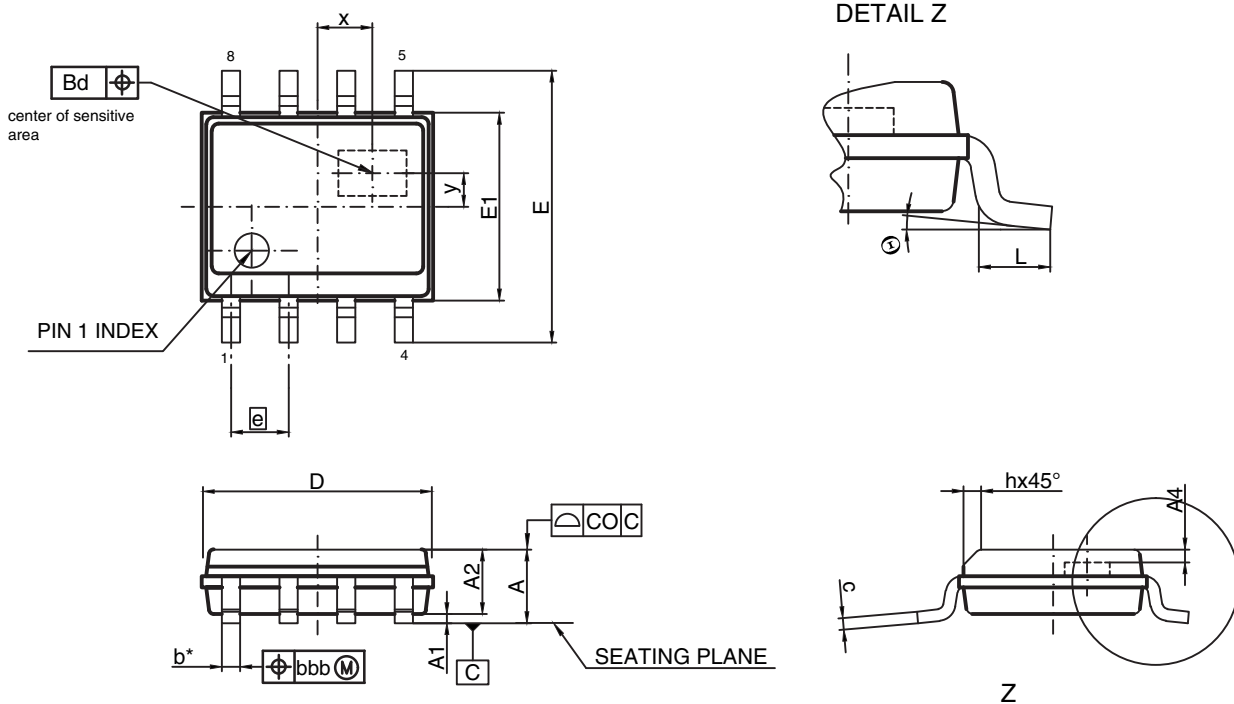
For calibration in the system environment, the application kit from Micronas is recommended. It contains the hardware for the generation of the serial telegram for programming and the corresponding LabView based programming environment for the input of the register values (see Section 6.2. on page 29).

For the individual calibration of each sensor in the customer application, a two point calibration is recommended.

A detailed description of the calibration software example provided by Micronas, calibration algorithm, programming sequences and register value calculation can be found in the Application Note “HAL 22xy Programming Guide”.

4. Specifications

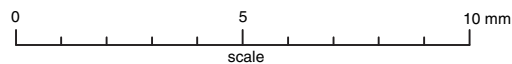
4.1. Outline Dimensions



"D" and "E1" are reference data and do not include mold flash or protrusion. Mold flash or protrusion shall not exceed 150 μm per side.

* does not include dambar protrusion of 0.1 max. per side

A4, Bd, x,y=these dimensions are different for each sensor type and are specified in the data sheet



UNIT	A	A1	A2	b	bbb	c	CO	D	E	E1	e	h	L	θ
mm	1.65	0.25 0.1	1.45	0.4	0.25	0.22	0.1	5.0 4.8	6.0	4.0 3.8	1.27	0.3	0.41 min.	8° max.

JEDEC STANDARD		ISSUE DATE YY-MM-DD	DRAWING-NO.	ZG-NO.
ISSUE	ITEM NO.			
F	MS-012	09-07-21	06690.0001.4 Bl. 1	ZG001090_Ver.05

© Copyright 2009 Micronas GmbH, all rights reserved

Fig. 4-1:
SOIC8-1: Plastic Small Outline IC package, 8 pins, gullwing bent, 150 mil
 Ordering code: DJ
 Weight approximately 0.086 g

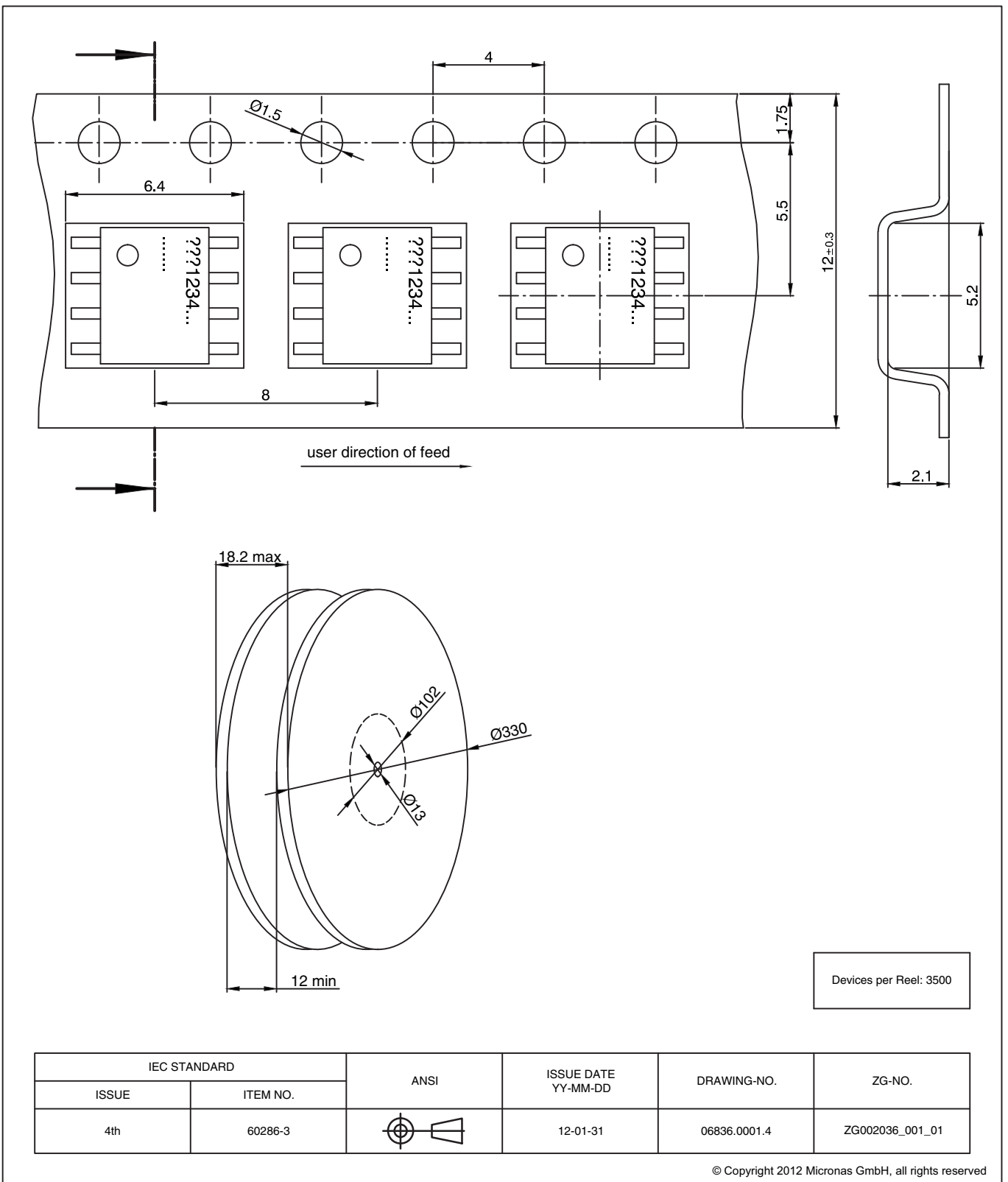


Fig. 4-2:
SOIC8: Tape and Reel Finishing

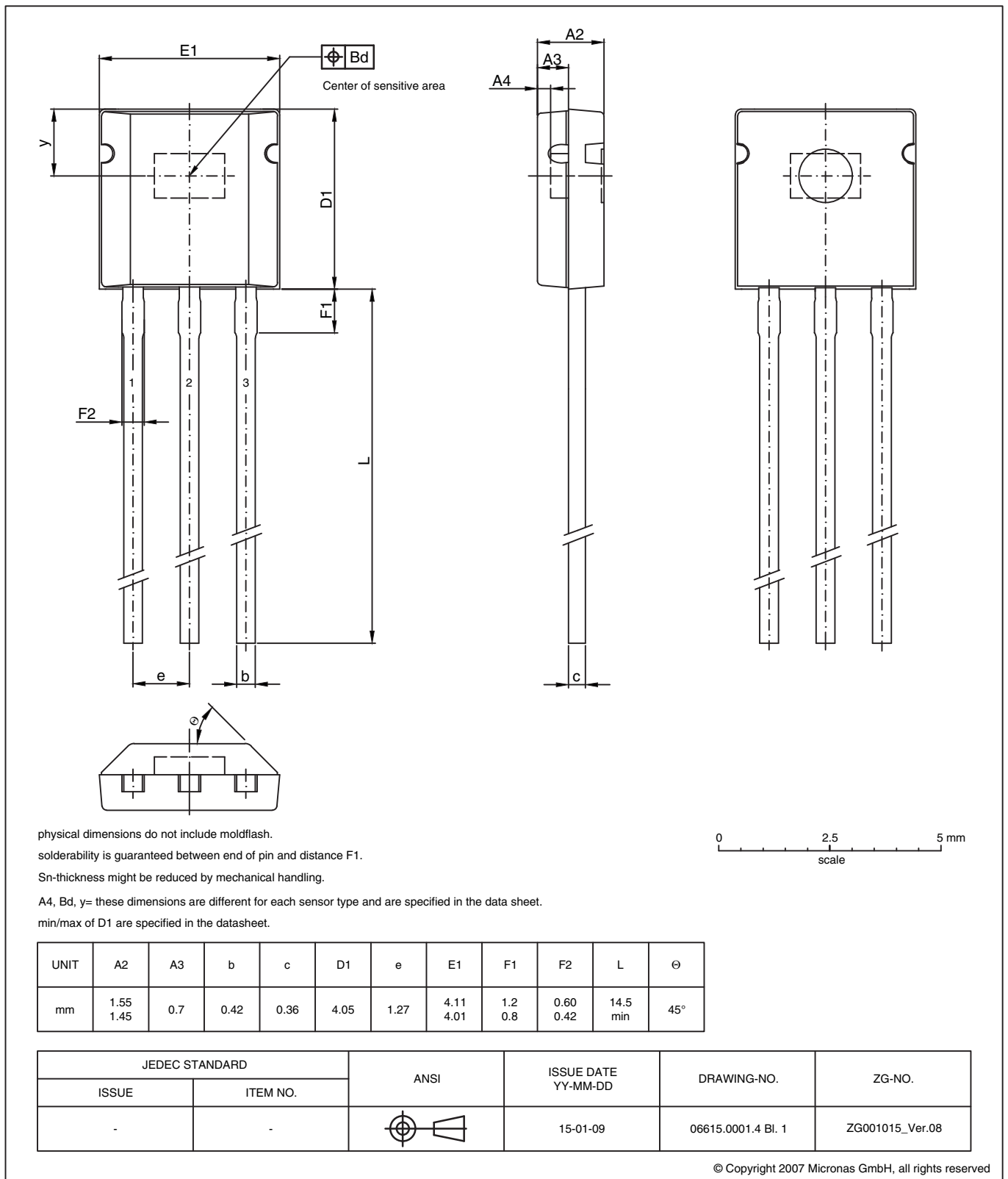


Fig. 4-3:
TO92UT-2 Plastic Transistor Standard UT package, 3 pins
 Weight approximately 0.12 g

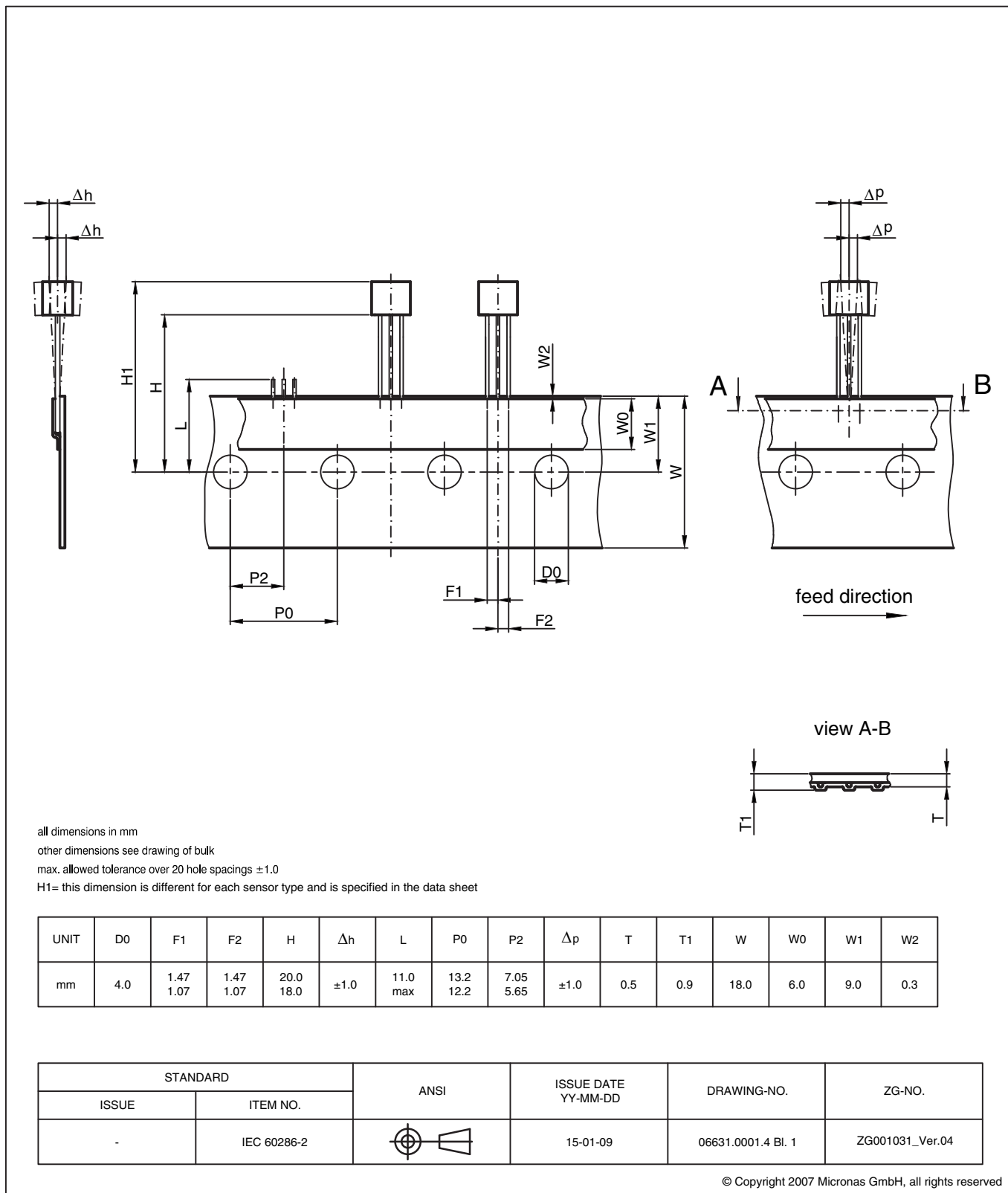


Fig. 4-5:
T092UA/UT: Dimensions ammpack inline, not spread

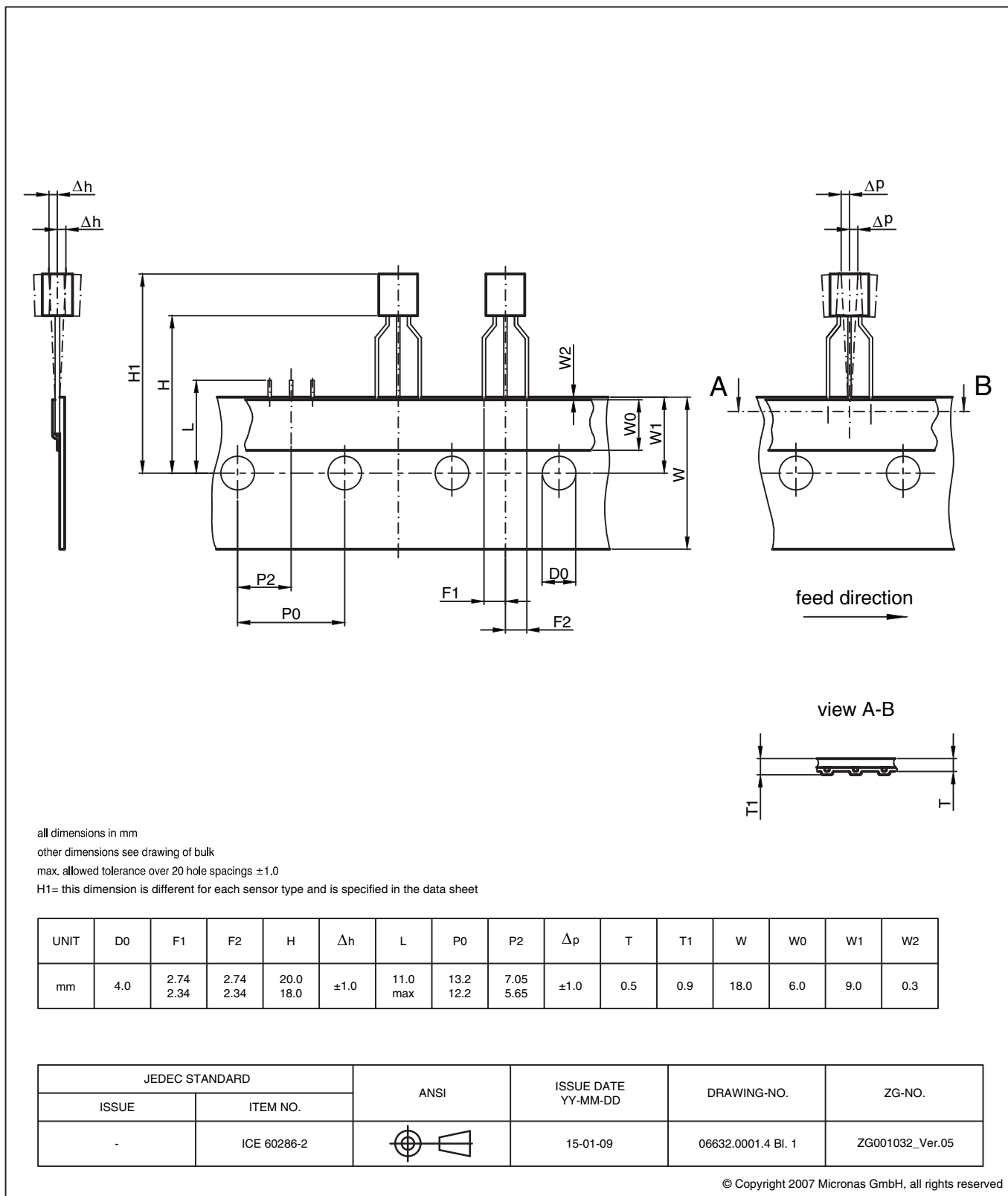


Fig. 4-6:
TO92UA/UT: Dimensions ammpack inline, spread

4.2. Soldering, Welding and Assembly

Information related to solderability, welding, assembly, and second-level packaging is included in the document “Guidelines for the Assembly of Micronas Packages”. It is available on the Micronas website (<http://www.micronas.com/en/service-center/downloads>) or on the service portal (<http://service.micronas.com>).

4.3. Pin Connections and Short Descriptions

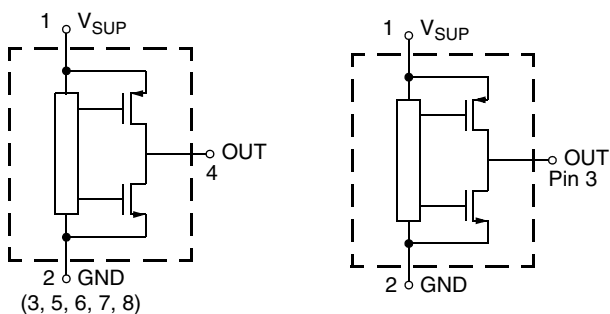
Table 4–1: SOIC8 package

Pin No	Pin Name	Type	Short Description
1	VSUP	SUPPLY	Supply Voltage
2	GND	GND	Ground
4	OUT	I/O	Output and Programming Pin

All remaining pins (3, 5, 6, 7, 8) must be connected to ground

Table 4–2: TO92UT package

Pin No	Pin Name	Type	Short Description
1	VSUP	SUPPLY	Supply Voltage
2	GND	GND	Ground
3	OUT	I/O	Output and Programming Pin



SOIC8 package

TO92UT package

Fig. 4–7: Pin configuration in SOIC8 and TO92UT package

4.4. Sensitive Area

4.4.1. Dimensions

250 μm x 250 μm

4.4.2. Package Parameter and Position

	SOIC8-1	TO92UT-1/-2
A4	0.48 mm nominal	0.4 mm nominal
Bd	0.3 mm	0.3 mm
x	0 mm nominal (center of package)	
y	0.13 mm nominal	1.55 mm nominal
D1	-	4.05 mm \pm 0.05 mm
H1	-	min. 22.0 mm max. 24.1 mm

4.5. Absolute Maximum Ratings

Stresses beyond those listed in the “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only. Functional operation of the device at these conditions is not implied. Exposure to absolute maximum rating conditions for extended periods will affect device reliability.

This device contains circuitry to protect the inputs and outputs against damage due to high static voltages or electric fields; however, it is advised that normal precautions be taken to avoid application of any voltage higher than absolute maximum-rated voltages to this circuit.

All voltages listed are referenced to ground (GND).

Symbol	Parameter	Pin	Min.	Max.	Unit	Condition
V_{SUP}	Supply Voltage	VSUP	-8.5 -18	10 18	V V	$t < 96 \text{ h}^{4)}$ $t < 1 \text{ h}^{4)}$
V_{OUT}	Output Voltage	OUT	-6 ¹⁾	18	V	$t < 1 \text{ h}^{4)}$
$V_{OUT} - V_{SUP}$	Excess of Output Voltage over Supply Voltage	VSUP, OUT	-	2	V	
T_J	Junction Temperature under Bias		-50	190 ²⁾	°C	
V_{ESD_SOIC8}	ESD Protection for SOIC8 package	VSUP, OUT	-8.0 ³⁾	8.0 ³⁾	kV	Pin 3 soldered and connected to GND.
			-2.0 ³⁾	2.0 ³⁾		Pin 3 not connected
V_{ESD_TO92}	ESD Protection for TO92UT package	VSUP, OUT	-8.0 ³⁾	8.0 ³⁾	kV	

¹⁾ internal protection resistor = 50 Ω
²⁾ For 96h, please contact Micronas for other temperature requirements.
³⁾ AEC-Q-100-002 (100 pF and 1.5 k Ω)
⁴⁾ No cumulated stress

4.5.1. Storage and Shelf Life

Information related to storage conditions of Micronas sensors is included in the document “Guidelines for the Assembly of Micronas Packages”. It gives recommendations linked to moisture sensitivity level and long-term storage.

It is available on the Micronas website (<http://www.micronas.com/en/service-center/downloads>) or on the service portal (<http://service.micronas.com>).

4.6. Recommended Operating Conditions

Functional operation of the device beyond those indicated in the “Recommended Operating Conditions/Characteristics” is not implied and may result in unpredictable behavior, reduce reliability and lifetime of the device.

All voltages listed are referenced to ground (GND).

Symbol	Parameter	Pin	Min.	Typ.	Max.	Unit	Remarks
V _{SUP}	Supply Voltage	VSUP	4.5 5.7	5 6	5.5 6.5	V	Normal operation During programming
I _{OUT}	Continuous Output Current	OUT	-1.2	-	5	mA	
R _L	Load Resistor	OUT	1.0	-	-	kΩ	Pull-up resistor only
C _L	Load Capacitance	OUT	-	0.18	10	nF	
N _{PRG}	Number of Memory Programming Cycles ¹⁾	-	-	-	100	cycles	0°C < T _{amb} < 55°C
T _J	Junction Temperature ²⁾	-	-40 -40 -40	-	125 150 170	°C	for 8000 h ³⁾ for 2000 h ³⁾ for 1000 h ³⁾
¹⁾ In the EEPROM, it is not allowed to program only one single address within a 'bank' in the memory. In case of programming one single address the complete bank has to be programmed ²⁾ Depends on the temperature profile of the application. Please contact Micronas for life time calculations. ³⁾ Time values are not cumulative							

4.7. Characteristics

at $T_J = -40\text{ }^\circ\text{C}$ to $+170\text{ }^\circ\text{C}$, $V_{SUP} = 4.5\text{ V}$ to 5.5 V , $GND = 0\text{ V}$, after programming and locking of the sensor, at Recommended Operating Conditions if not otherwise specified in the column “Conditions”.
 Typical Characteristics for $T_J = 25\text{ }^\circ\text{C}$ and $V_{SUP} = 5\text{ V}$.

Symbol	Parameter	Pin	Limit Values			Unit	Test Conditions
			Min.	Typ.	Max.		
I_{SUP}	Supply Current over Temperature Range	VSUP	–	7	10	mA	
	Resolution ¹⁾	OUT	–	12	–	bit	depends on PWM Period
$t_{r(O)}$	Response Time of Output ²⁾	OUT	- - - -	1.5 2.5 4.5 8.5	1.8 3 5.4 10.2	ms	$f_{PWM} = 2\text{ kHz}$ $f_{PWM} = 1\text{ kHz}$ $f_{PWM} = 500\text{ Hz}$ $f_{PWM} = 250\text{ Hz}$
$t_{\Delta Vs}$	Wake-up time ²⁾	OUT	–	–	1.7	ms	$C_L = 10\text{ nF}$
V_{OUTL}	Output Low Voltage	OUT	–	0.5	–	V	$V_{SUP} = 5\text{ V}$, $I_{OUT} < 5\text{ mA}$
$OUT_{NOISErms}$	Output Noise RMS ²⁾	OUT	–	0.05	0.1	%	BARREL SHIFTER=3 Overall gain in signal path =1 External circuitry according to Fig. 5–1 with low-noise supply Related to 12 bit full scale
f_{PWM}	PWM Frequency ²⁾	OUT	1.7 0.85 0.425 0.213	2 1 0.5 0.25	2.3 1.15 0.575 0.288	kHz	Customer programmable
J_{PWM}	RMS PWM Jitter ²⁾	OUT	–	1	2	LSB ₁₂	$f_{PWM} = 1\text{ kHz}$
t_{rise}	Rise Time of Digital Output ²⁾	OUT	–	0.4	–	μs	R_L Pull-up = $1\text{ k}\Omega$, $C_L = 1\text{ nF}$
t_{fall}	Fall Time of Digital Output ²⁾	OUT	–	0.5	–	μs	R_L Pull-up = $1\text{ k}\Omega$, $C_L = 1\text{ nF}$
ROUT_DIG	On Resistance of Digital Pull-Up Driver ²⁾	OUT	–	100	200	Ω	Includes $25\text{ }\Omega$ series pull-up resistor and $50\text{ }\Omega$ pull-down
SOIC8 Package							
R_{thja}	Thermal Resistance Junction to Air	–	–	–	142	K/W	Measured with a 1s0p board
R_{thjc}	Junction to Case	–	–	–	88	K/W	Measured with a 1s1p board
		–	–	–	33	K/W	Measured with a 1s0p board
		–	–	–	22	K/W	Measured with a 1s1p board
TO92UT Package							
R_{thja}	Thermal Resistance Junction to Air	–	–	–	235	K/W	Measured with a 1s0p board
R_{thjc}	Junction to Case	–	–	–	159	K/W	Measured with a 1s1p board
		–	–	–	61	K/W	Measured with a 1s0p board
		–	–	–	45	K/W	Measured with a 1s1p board
¹⁾ Guaranteed by Design ²⁾ Characterized on small sample size, not tested.							

4.8. Overvoltage and Undervoltage Detection

at $T_J = -40\text{ °C}$ to $+170\text{ °C}$, Typical Characteristics for $T_J = 25\text{ °C}$, after programming and locking

Symbol	Parameter	Pin	Min.	Typ.	Max.	Unit	Test Conditions
$V_{SUP,UV}$	Undervoltage Detection Level	VSUP	3.3	3.9	4.3	V	
$V_{SUP,UVhyst}$	Undervoltage Detection Level Hysteresis ¹⁾	VSUP	–	200	–	mV	
$V_{SUP,OV}$	Overvoltage Detection Level	VSUP	5.6	6.2	6.9	V	
$V_{SUP,OVhyst}$	Overvoltage Detection Level Hysteresis ¹⁾	VSUP	–	225	–	mV	

1) Characterized on small sample size, not tested

4.9. Magnetic Characteristics

at $T_J = -40\text{ °C}$ to $+170\text{ °C}$, $V_{SUP} = 4.5\text{ V}$ to 5.5 V , $GND = 0\text{ V}$ after programming and locking, at Recommended Operating Conditions if not otherwise specified in the column “Conditions”. Typical Characteristics for $T_J = 25\text{ °C}$ and $V_{SUP} = 5\text{ V}$.

Symbol	Parameter	Pin No.	Min.	Typ.	Max.	Unit	Test Conditions
SENS	Magnetic Sensitivity ¹⁾	–	–	–	170	mV/ mT	Programmable $V_{SUP} = 5\text{ V}$ and $T_J = 25\text{ °C}$; BARREL SHIFTER = $\pm 12\text{ mT}$ $\Delta V_{OUT} = 4\text{ V}$
$RANGE_{ABS}$	Absolute Range of CFX Register (Magnetic Range) ¹⁾	–	100	200	235	%	See Section 3.2. on page 7 for CFX register definition.
B_{Offset}	Magnetic Offset ¹⁾	OUT	–0.4	0	0.4	mT	$B = 0\text{ mT}$, $I_{OUT} = 0\text{ mA}$, $T_J = 25\text{ °C}$, unadjusted sensor
$\Delta B_{Offset}/\Delta T$	Magnetic Offset Change due to T_J ¹⁾	OUT	–5	0	5	$\mu\text{T/K}$	$B = 0\text{ mT}$, $I_{OUT} = 0\text{ mA}$ BARREL SHIFTER = 3 ($\pm 50\text{ mT}$)
ES	Error in Magnetic Sensitivity	OUT	–1 –1.5	0 0	+1 +1.5	%	TO92 package, $V_{SUP} = 5\text{ V}$, BARREL SHIFTER = 3 ($\pm 50\text{ mT}$) SOIC8 package, $V_{SUP} = 5\text{ V}$, BARREL SHIFTER = 3 ($\pm 50\text{ mT}$)

1) Characterized on small sample size, not tested